



COLLEGE OF ENGINEERING, PUNE

(An Autonomous Institute of Government of Maharashtra.)
SHIVAJI NAGAR, PUNE - 411 005

END Semester Examination

(OE) PE 14004- Micro-Electro Mechanical Systems TH

Course: B.Tech

Branch: Production Engineering (Sandwich)

Semester: Sem VII

Year: 2014-2015

Max.Marks:60

Duration: 3 Hours Time:- 2 to 5 p.m.

Date: 12-12-2014

Instructions:

MIS No.

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1. Figures to the right indicate the full marks.
2. Mobile phones and programmable calculators are strictly prohibited.
3. Writing anything on question paper is not allowed.
4. Exchange/Sharing of anything like stationery, calculator is not allowed.
5. Assume suitable data if necessary.
6. Write your MIS Number on Question Paper
7. Attempt any SIX questions.

- Q1. Give atleast five distinct advantages of miniaturization of machines and devices. (5)
- Q2. Explain the importance of piezoelectric and shape memory materials in MEMS devices with a suitable example of each. (5)
- Q3. Describe DRIE process. How can this process achieve virtually perfect virtual etching? (5)
- Q4. Briefly explain the fabrication steps in LIGA process. What are the major advantages of this process? What is SLIGA? (5)
- Q5. A CVD process involves a reactant being diluted to 1.8 percent in the carrier oxygen gas at 490°C. Find the number of molecules in cubic meter volume of the carrier gas. Pressure variation in the process is negligible. The CVD process is carried out in a horizontal reactor. Determine the following: (10)
- i) Density of carrier gas
 - ii) Reynolds number of the gas flow
 - iii) Thickness of the boundary layer over the substrate surface
 - iv) Surface reaction rate
 - v) Deposition rate

OR

A silicon substrate is subjected to diffusion of boron dopant at 1000°C, 900°C and 800°C (10) with a dose $10^{12}/\text{cm}^2$. Find the expression for estimating the concentration of dopant in the substrate. Also find the concentration at 0.25 μm beneath the surface after 1 hour into the diffusion process.

What observations will you make for this exercise?

- Q6. a. Explain the construction and working of electrostatically actuated micropump. State the applications of such a device. (10)
- Q7. State the need of Microsystems packaging. Explain three level Microsystems packaging with a neat sketch. (10)
- Q8. What are scaling laws and explain any of them. (5)
- Q9. Write short notes on the following (Any TWO): (5)
- Design and fabrication of microgripper
 - Ion implantation
 - Photoresist types and materials

Table 1

Ion implantation of common dopants in silicon

Ion	Range R_p , nm	Straggle, ΔR_p , nm
<i>At 30 keV energy level</i>		
Boron	106.5	39
Phosphorus	42	19.5
Arsenic	23.3	9.0
<i>At 100 keV energy level</i>		
Boron	307	69
Phosphorus	135	53.5
Arsenic	67.8	26.1

Table 2

Dopants	Constant, a	Constant, b
Boron	-19.9820	13.1109
Arsenic	-26.8404	17.2250
Phosphorus($N_s=10^{21}/\text{cm}^3$)	-15.8456	11.1168
Phosphorus($N_s=10^{19}/\text{cm}^3$)	-20.4278	13.6430